

**Search Notes**

Application/Control No.

10/658,361

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under  
Reexamination

OTSUKI, KOICHI

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	37,14,34 36,75	8/18/2006	SWH
358	1.14,1.16	8/18/2006	SWH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPGPUB text search (see attached)	8/18/2006	SWH